N-channel QFN3333 40 V 7.0 mΩ standard level MOSFET Rev. 2 — 18 August 2010 Product data

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel MOSFET in QFN3333 package qualified to 150 °C. This product is designed and qualified for use in a wide range of industrial, communications and power supply equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Small footprint for compact designs

1.3 Applications

- DC-to-DC converters
- Lithium-ion battery protection

- Suitable for standard level gate drive sources
- Load switching
- Power ORing

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	40	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u>	-	-	40	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	65	W
Tj	junction temperature		-55	-	150	°C
Static cha	racteristics					
R _{DSon}	drain-source on-state	V _{GS} = 10 V; I _D = 10 A; T _j = 100 °C; see <u>Figure 12</u>	-	-	10	mΩ
	resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 13}{100000000000000000000000000000000000$	-	5.6	7	mΩ



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able 1.	Quick	reference	data	continued
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Table 1.	Quick reference da	tacontinued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic	characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; \text{ I}_{D} = 30 \text{ A};$	-	4.6	-	nC
Q _{G(tot)}	total gate charge	V _{DS} = 20 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	21.4	-	nC
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy		-	-	64	mJ

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source		
3	S	source		
4	G	gate		
5,6,7,8	D	drain		mbb076 S
mb	D	mounting base; connected to drain	Transparent top view	
			SOT873-1 (QFN3333)	

Ordering information 3.

Table 3. Ordering in	nformation		
Type number	Package		
	Name	Description	Version
PSMN7R0-40LS	QFN3333	plastic thermal enhanced very thin small outline package; no leads; 8 terminals	SOT873-1

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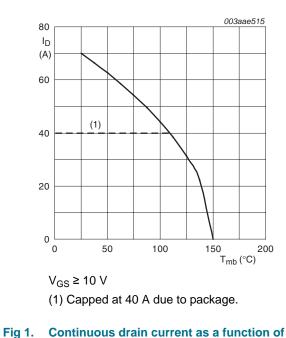
N-channel QFN3333 40 V 7.0 mΩ standard level MOSFET

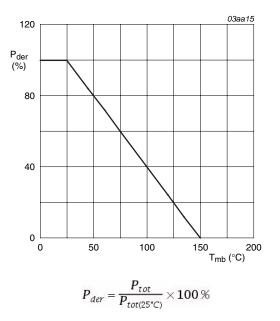
4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	40	V
V _{DGR}	drain-gate voltage	T _j ≥ 25 °C; T _j ≤ 150 °C; R _{GS} = 20 kΩ	-	40	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	40	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u>	-	40	А
I _{DM}	peak drain current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C; see <u>Figure 3</u>	-	280	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	65	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-drai	n diode				
I _S	source current	T _{mb} = 25 °C	-	40	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$	-	280	А
Avalanche r	uggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 40 A; $V_{sup} \le 40$ V; unclamped; R_{GS} = 50 Ω	-	64	mJ



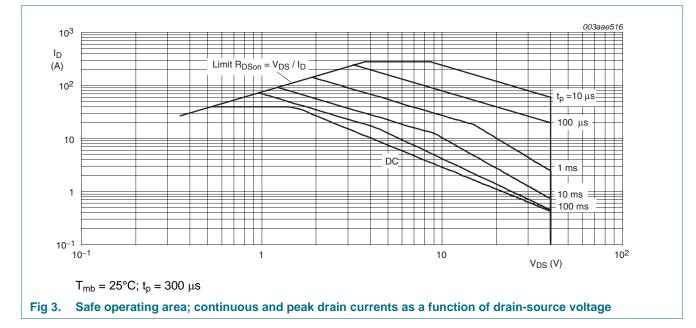






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5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4		-	1	1.3	K/W
R _{th(j-a)}	thermal resistance from junction to ambient		<u>[1]</u>	-	53	60	K/W

 R_{th(j-a)} is guaranteed by design and assumes that the device is mounted on a 40mm x 40mm x 70µm copper pad at 20°C ambient temperature. In practice R_{th(j-a)} will be determined by the customer's PCB characteristics

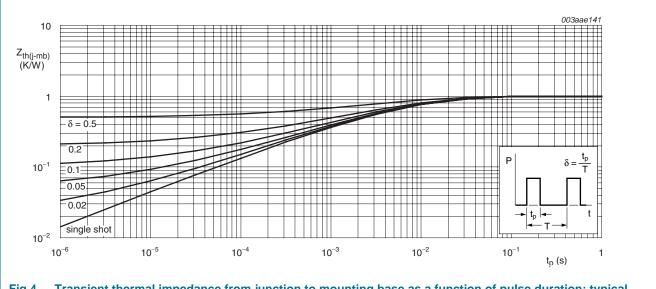


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

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6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$	36	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	40	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 10</u>	-	-	4.7	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C};$ see Figure 10	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 10; see Figure 11	2.3	3	4	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.1	2	μA
		V_{DS} = 40 V; V_{GS} = 0 V; T_j = 125 °C	-	-	50	μA
I _{GSS}	gate leakage current	V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 10 A; T _j = 100 °C; see <u>Figure 12</u>	-	-	10	mΩ
		V_{GS} = 10 V; I _D = 10 A; T _j = 150 °C; see <u>Figure 12</u>	-	9.5	11.9	mΩ
		V_{GS} = 10 V; I _D = 10 A; T _j = 25 °C; see Figure 13	-	5.6	7	mΩ
R _G	internal gate resistance (AC)	f = 1 MHz	-	0.9	-	Ω
Dynamic ch	aracteristics					
Q _{G(tot)}	total gate charge	$I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}$	-	18.2	-	nC
		$I_D = 30 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$	-	21.4	-	nC
Q _{GS}	gate-source charge	see Figure 14; see Figure 15	-	7.9	-	nC
Q _{GS(th)}	pre-threshold gate-source charge		-	3.8	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge		-	4	-	nC
Q _{GD}	gate-drain charge		-	4.6	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 30 \text{ A}; V_{DS} = 20 \text{ V}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 15}$	-	5.4	-	V
C _{iss}	input capacitance	$V_{DS} = 12 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	1286	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 16}{100}$	-	278	-	pF
C _{rss}	reverse transfer capacitance		-	149	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 20 \text{ V}; \text{R}_{L} = 0.67 \Omega; \text{V}_{GS} = 10 \text{ V}; \label{eq:VDS}$	-	11	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \ \Omega$	-	32	-	ns
t _{d(off)}	turn-off delay time		-	19	-	ns
				5.9		

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Symbol

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Max

Unit

Тур

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Min

ymsor	i di dinettei						
ource-dra							
D	source-drain voltage	$I_S = 17 \text{ A}; V_{GS} = 0 \text{ V}; T_j = $ see <u>Figure 17</u>	25 °C;	-	0.85	1.2	V
	reverse recovery time	$I_{\rm S} = 30 \text{ A}; dI_{\rm S}/dt = -100 \text{ A}/$	/μs; V _{GS} = 0 V;	-	26.2	-	ns
	recovered charge	V _{DS} = 20 V		-	18.8	-	nC
		003aae518				003aae519	
60			⁵⁰ I _D 7.0 6.0	V _{GS} (V) = 5.5		
9fs			(A) 10				
(S)			40				
40							
			30			5.0	
_						5.0	
			20			4.8	
20 -				\square			
			10			4.6	
						4.4	
						4.2	
0	10 20 3	30 40	0 0 0.5	1	1.5		
0		30 _{ID (A)} 40	0 0.5			4.2 V _{DS} (V) ²	
o Tj :	= 25°C; V _{DS} = 10 V	I _D (A)	0 0.5 T _j = 25°C and	t _p = 300 μs		V _{DS} (V) ²	
0 Tj : Fig 5. Fo	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A)	0 0.5 $T_j = 25^{\circ}C$ and 6. Output chara	t _p = 300 μs cteristics:	drain cu	V _{DS} (V) ²	
0 Tj : Fig 5. Fo	= 25°C; V _{DS} = 10 V	I _D (A)	0 0.5 T _j = 25°C and	t _p = 300 μs cteristics:	drain cu	V _{DS} (V) ²	
0 Tj⊧ Fig 5. Fo dra	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A)	0 0.5 T _j = 25°C and 6. Output chara function of dr	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj Fig 5. Fo dra ⁴⁰ □	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	0 0.5 $T_j = 25^{\circ}C$ and 6. Output chara	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
₀ Tj Fig 5. Fo dra	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	$\begin{array}{c} 0 & 0.5 \\ T_{j} = 25^{\circ}C \text{ and} \\ \hline \textbf{6. Output chara function of dr} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \end{array} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \end{array} \\ \hline \end{array} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \\ \hline$	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : Fig 5. Fo dra 40 ID	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	0 0.5 $T_j = 25^{\circ}C$ and 6. Output chara function of dr	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : Fig 5. Fo dra 40 ID (A)	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $\frac{20}{\text{RDSon}}$ 16	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : Fig 5. Fo dra 40 ID (A)	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	$\begin{array}{c} 0 & 0.5 \\ T_{j} = 25^{\circ}C \text{ and} \\ \hline \textbf{6. Output chara function of dr} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \end{array} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \end{array} \\ \hline \end{array} \\ \hline \begin{array}{c} 20 \\ \hline \end{array} \\ \hline \\ \hline$	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : Fig 5. Fo dra 40 ID (A)	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $\frac{20}{\text{RDSon}}$ 16	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : ig 5. Fo dra ⁴⁰ (A) 30	= 25°C; V _{DS} = 10 V prward transconductance a ain current; typical values	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $\frac{20}{\text{RDSon}}$ 16	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Fig 5. Fo dra 40 (A) 30 20	= 25°C; V _{DS} = 10 V prward transconductance a	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $T_{j} = 25^{\circ}C$	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : fig 5. Fo dra 40 (A) 30	= 25°C; V _{DS} = 10 V prward transconductance a ain current; typical values	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $T_{j} = 25^{\circ}C$	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Tj : Fig 5. Fo dra 40 (A) 30 20	= 25°C; V _{DS} = 10 V prward transconductance a ain current; typical values	ID (A)	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $T_{j} = 25^{\circ}C$	t _p = 300 μs cteristics:	drain cu e voltage	V _{DS} (V) ²	
0 Fig 5. Fo dra (A) 30 20 10 10	= 25°C; V_{DS} = 10 V prward transconductance a ain current; typical values $T_j = 175$ °C	ID (A)	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $\frac{20}{\text{RDSon}}$ 16 12 8 4 0	t _p = 300 μs cteristics: rain-source	drain cu voltage	V _{DS} (V) ²	l value
0 Fig 5. Fo dra 10 (A) 30 20 10	= 25°C; V _{DS} = 10 V prward transconductance a ain current; typical values	ID (A)	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $T_{j} = 25^{\circ}C$	t _p = 300 μs cteristics:	drain cu voltage	V _{DS} (V) ²	l value
0 Tj : ig 5. Fo dra (A) 30 20 10 10 0 0	= 25°C; V_{DS} = 10 V prward transconductance a ain current; typical values $T_j = 175$ °C 2 4	I _D (A) as a function of Fig	$T_{j} = 25^{\circ}C \text{ and}$ 6. Output chara function of dr $\frac{20}{\text{ADSon}}$ 16 12 4 4 0 4 4 0 4 8 4 4 0 4 8 4 4 4 4 4 4 4	t _p = 300 μs cteristics: rain-source	drain cu voltage	V _{DS} (V) ²	l value
0 Fig 5. Fo dra 40 10 (A) 30 20 10 0 VD	= 25°C; V_{DS} = 10 V prward transconductance a ain current; typical values $T_j = 175$ °C	I _D (A) as a function of Fig $\begin{array}{c} 003aae520\\ \hline \\ \hline$	T _j = 25°C and 6. Output chara function of dr R_{DSon} $(m\Omega)$ 16 12 8 4 4 5 T _j = 25°C; I _D =	t _p = 300 μs cteristics: rain-source	drain cu voltage	V _{DS} (V) ²	l value

Table 6. Characteristics ...continued

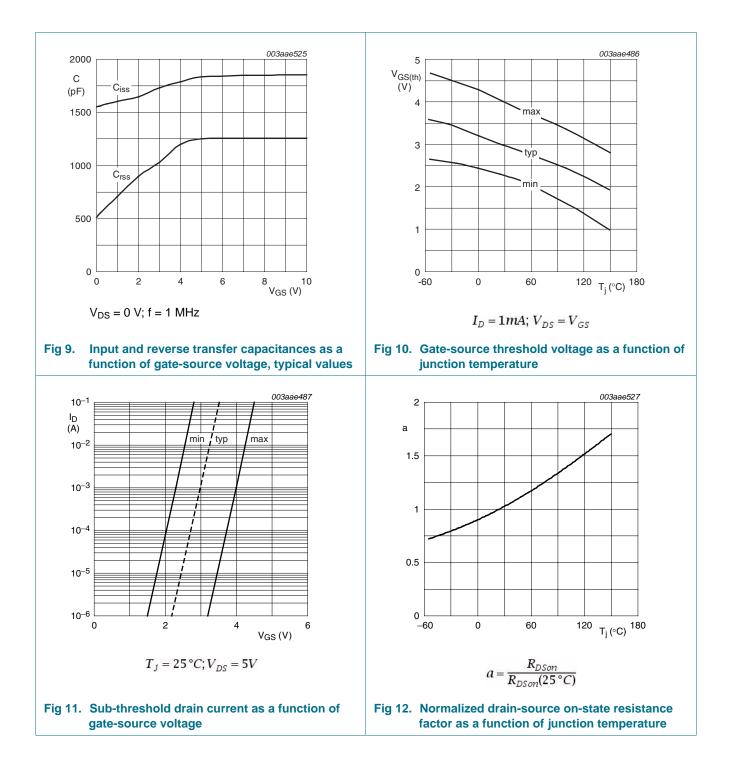
Parameter

Conditions

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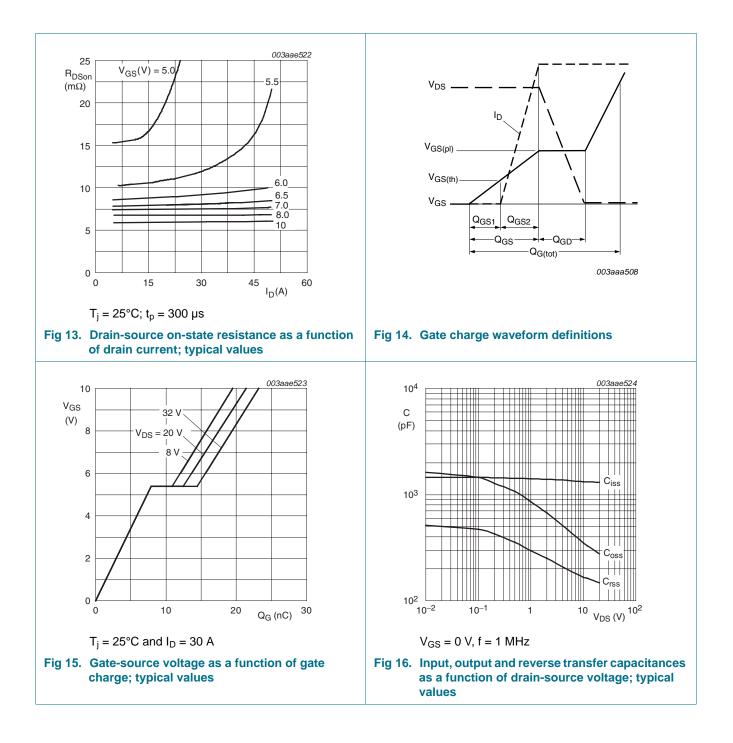
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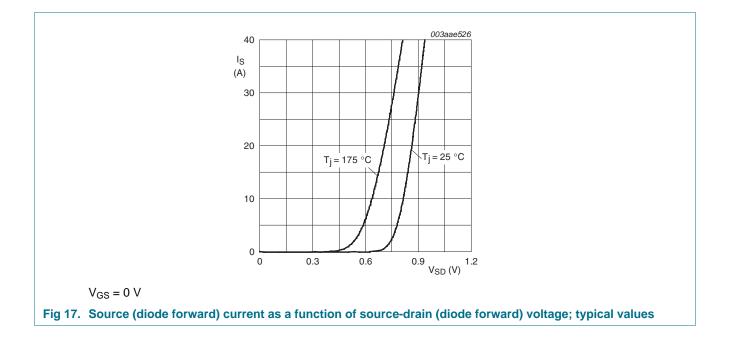


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7. Package outline

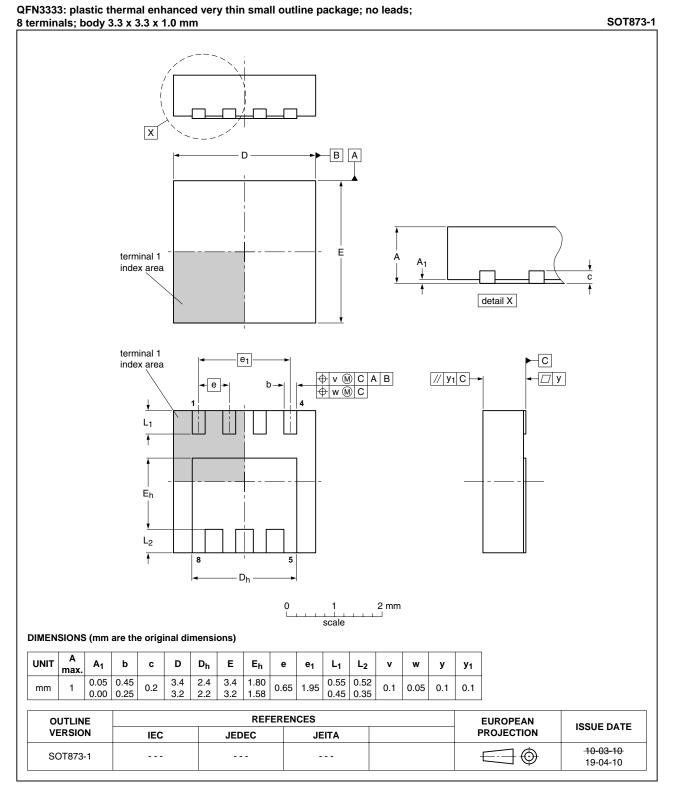


Fig 18. Package outline SOT873-1 (QFN3333)

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8. Revision history

Table 7. Revision h	nistory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN7R0-40LS v.2	20100818	Product data sheet	-	PSMN7R0-40LS v.1
Modifications:	 Status changed 	from objective to product.		
PSMN7R0-40LS v.1	20100624	Objective data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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N-channel QFN3333 40 V 7.0 mΩ standard level MOSFET

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